Search Notes



Application/Control N

10/722,100

Examiner

Sheng-Jen Tsai

Applicant(s)/Patent under Reexamination

BUCHTY ET AL.

Art Unit

2186

SEARCHED				
Class	Subclass	Date	Examiner	
711	221	4/3/2006	SJT	
711	220	4/3/2006	SJT	
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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	DATE	EXMR
East: "address generation" "address generator" "address generation" with "vector" "bit replacement"	4/3/2006	SJT
"address generation" with "multi port" "address generation " with "dual port"	4/3/2006	SJT
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